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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### Details

Product Status	Active
Number of LABs/CLBs	3411
Number of Logic Elements/Cells	43661
Total RAM Bits	2138112
Number of I/O	358
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	676-BGA
Supplier Device Package	676-FBGA (27x27)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc6slx45-3fgg676c">https://www.e-xfl.com/product-detail/xilinx/xc6slx45-3fgg676c</a>

Table 2: Recommended Operating Conditions<sup>(1)</sup>

Symbol	Description			Min	Typ	Max	Units	
$V_{CCINT}$	Internal supply voltage relative to GND	-3, -3N, -2	Standard performance <sup>(2)</sup>	1.14	1.2	1.26	V	
		-3, -2	Extended performance <sup>(2)</sup>	1.2	1.23	1.26	V	
		-1L	Standard performance <sup>(2)</sup>	0.95	1.0	1.05	V	
$V_{CCAUX}^{(3)(4)}$	Auxiliary supply voltage relative to GND	$V_{CCAUX} = 2.5V^{(5)}$			2.375	2.5	2.625	V
		$V_{CCAUX} = 3.3V$			3.15	3.3	3.45	V
$V_{CCO}^{(6)(7)(8)}$	Output supply voltage relative to GND			1.1	—	3.45	V	
$V_{IN}$	Input voltage relative to GND	All I/O standards (except PCI)	Commercial temperature (C)	-0.5	—	4.0	V	
			Industrial temperature (I)	-0.5	—	3.95	V	
			Expanded (Q) temperature	-0.5	—	3.95	V	
		PCI I/O standard <sup>(9)</sup>	—	-0.5	—	$V_{CCO} + 0.5$	V	
$I_{IN}^{(10)}$	Maximum current through pin using PCI I/O standard when forward biasing the clamp diode. <sup>(9)</sup>	Commercial (C) and Industrial temperature (I)			—	—	10	mA
		Expanded (Q) temperature			—	—	7	mA
$V_{BATT}^{(11)}$	Battery voltage relative to GND, $T_j = 0^\circ\text{C}$ to $+85^\circ\text{C}$ (LX75, LX75T, LX100, LX100T, LX150, and LX150T only)			1.0	—	3.6	V	
$T_j$	Junction temperature operating range	Commercial (C) range			0	—	85	$^\circ\text{C}$
		Industrial temperature (I) range			-40	—	100	$^\circ\text{C}$
		Expanded (Q) temperature range			-40	—	125	$^\circ\text{C}$

**Notes:**

1. All voltages are relative to ground.
2. See *Interface Performances for Memory Interfaces* in Table 25. The extended performance range is specified for designs not using the standard  $V_{CCINT}$  voltage range. The standard  $V_{CCINT}$  voltage range is used for:
  - Designs that do not use an MCB
  - LX4 devices
  - Devices in the TQG144 or CPG196 packages
  - Devices with the -3N speed grade
3. Recommended maximum voltage droop for  $V_{CCAUX}$  is 10 mV/ms.
4. During configuration, if  $V_{CCO\_2}$  is 1.8V, then  $V_{CCAUX}$  must be 2.5V.
5. The -1L devices require  $V_{CCAUX} = 2.5V$  when using the LVDS\_25, LVDS\_33, BLVDS\_25, LVPECL\_25, RSDS\_25, RSDS\_33, PPDS\_25, and PPDS\_33 I/O standards on inputs. LVPECL\_33 is not supported in the -1L devices.
6. Configuration data is retained even if  $V_{CCO}$  drops to 0V.
7. Includes  $V_{CCO}$  of 1.2V, 1.5V, 1.8V, 2.5V, and 3.3V.
8. For PCI systems, the transmitter and receiver should have common supplies for  $V_{CCO}$ .
9. Devices with a -1L speed grade do not support Xilinx PCI IP.
10. Do not exceed a total of 100 mA per bank.
11.  $V_{BATT}$  is required to maintain the battery backed RAM (BBR) AES key when  $V_{CCAUX}$  is not applied. Once  $V_{CCAUX}$  is applied,  $V_{BATT}$  can be unconnected. When BBR is not used, Xilinx recommends connecting to  $V_{CCAUX}$  or GND. However,  $V_{BATT}$  can be unconnected.

Table 4: DC Characteristics Over Recommended Operating Conditions

Symbol	Description	Min	Typ	Max	Units
$V_{DRINT}$	Data retention $V_{CCINT}$ voltage (below which configuration data might be lost)	0.8	—	—	V
$V_{DRAUX}$	Data retention $V_{CCAUX}$ voltage (below which configuration data might be lost)	2.0	—	—	V
$I_{REF}$	$V_{REF}$ leakage current per pin for commercial (C) and industrial (I) devices	-10	—	10	$\mu A$
	$V_{REF}$ leakage current per pin for expanded (Q) devices	-15	—	15	$\mu A$
$I_L$	Input or output leakage current per pin (sample-tested) for commercial (C) and industrial (I) devices	-10	—	10	$\mu A$
	Input or output leakage current per pin (sample-tested) for expanded (Q) devices	-15	—	15	$\mu A$
$I_{HS}$	Leakage current on pins during hot socketing with FPGA unpowered	All pins except PROGRAM_B, DONE, and JTAG pins when HSWAPEN = 1	-20	—	20 $\mu A$
		PROGRAM_B, DONE, and JTAG pins, or other pins when HSWAPEN = 0	$I_{HS} + I_{RPU}$		$\mu A$
$C_{IN}^{(1)}$	Die input capacitance at the pad	—	—	10	pF
$I_{RPU}$	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 3.3V$ or $V_{CCAUX} = 3.3V$	200	—	500	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 2.5V$ or $V_{CCAUX} = 2.5V$	120	—	350	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.8V$	60	—	200	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.5V$	40	—	150	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.2V$	12	—	100	$\mu A$
$I_{RPD}$	Pad pull-down (when selected) @ $V_{IN} = V_{CCO}$ , $V_{CCAUX} = 3.3V$	200	—	550	$\mu A$
	Pad pull-down (when selected) @ $V_{IN} = V_{CCO}$ , $V_{CCAUX} = 2.5V$	140	—	400	$\mu A$
$I_{BATT}^{(2)}$	Battery supply current	—	—	150	nA
$R_{DT}^{(3)}$	Resistance of optional input differential termination circuit, $V_{CCAUX} = 3.3V$	—	100	—	$\Omega$
$R_{IN\_TERM}^{(5)}$	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_25) for commercial (C) and industrial (I) devices	23	25	55	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_25) for expanded (Q) devices	20	25	55	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_50) for commercial (C) and industrial (I) devices	39	50	72	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_50) for expanded (Q) devices	32	50	74	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_75) for commercial (C) and industrial (I) devices	56	75	109	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_75) for expanded (Q) devices	47	75	115	$\Omega$
$R_{OUT\_TERM}$	Thevenin equivalent resistance of programmable output termination (UNTUNED_25)	11	25	52	$\Omega$
	Thevenin equivalent resistance of programmable output termination (UNTUNED_50)	21	50	96	$\Omega$
	Thevenin equivalent resistance of programmable output termination (UNTUNED_75)	29	75	145	$\Omega$

**Notes:**

1. The  $C_{IN}$  measurement represents the die capacitance at the pad, not including the package.
2. Maximum value specified for worst case process at 25°C. LX75, LX75T, LX100, LX100T, LX150, and LX150T only.
3. Refer to IBIS models for  $R_{DT}$  variation and for values at  $V_{CCAUX} = 2.5V$ . IBIS values for  $R_{DT}$  are valid for all temperature ranges.
4.  $V_{CCO2}$  is not required for data retention. The minimum  $V_{CCO2}$  for power-on reset and configuration is 1.65V.
5. Termination resistance to a  $V_{CCO}/2$  level.

Table 5: Typical Quiescent Supply Current (Cont'd)

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
$I_{CCAUQ}$	Quiescent $V_{CCAU}$ supply current	LX4	2.5	2.5	2.5	2.5	mA
		LX9	2.5	2.5	2.5	2.5	mA
		LX16	3.0	3.0	3.0	3.0	mA
		LX25	4.0	4.0	4.0	4.0	mA
		LX25T	4.0	4.0	4.0	N/A	mA
		LX45	5.0	5.0	5.0	5.0	mA
		LX45T	5.0	5.0	5.0	N/A	mA
		LX75	7.0	7.0	7.0	7.0	mA
		LX75T	7.0	7.0	7.0	N/A	mA
		LX100	9.0	9.0	9.0	9.0	mA
		LX100T	9.0	9.0	9.0	N/A	mA
		LX150	12.0	12.0	12.0	12.0	mA
		LX150T	12.0	12.0	12.0	N/A	mA

**Notes:**

1. Typical values are specified at nominal voltage, 25°C junction temperatures ( $T_j$ ). Industrial (I) grade devices have the same typical values as commercial (C) grade devices at 25°C, but higher values at 100°C. Use the XPE tool to calculate 100°C values. Nominal  $V_{CCINT}$  is 1.20V; use the XPE tool to calculate 1.23V values for the nominal  $V_{CCINT}$  of the extended performance range.
2. Typical values are for blank configured devices with no output current loads, no active input pull-up resistors, all I/O pins are 3-state and floating.
3. If differential signaling is used, more accurate quiescent current estimates can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.

Table 6: Power Supply Ramp Time

Symbol	Description	Speed Grade	Ramp Time	Units
$V_{CCINTR}$	Internal supply voltage ramp time	-3, -3N, -2	0.20 to 50.0	ms
		-1L	0.20 to 40.0	ms
$V_{CCO2}$ <sup>(1)</sup>	Output drivers bank 2 supply voltage ramp time	All	0.20 to 50.0	ms
$V_{CCAU}$	Auxiliary supply voltage ramp time	All	0.20 to 50.0	ms

**Notes:**

1. The minimum  $V_{CCO2}$  for power-on reset and configuration is 1.65V.
2. Spartan-6 FPGAs require a certain amount of supply current during power-on to insure proper device initialization. The actual current consumed depends on the power-on ramp rate of the power supply. Use the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools to estimate current drain on these supplies. Spartan-6 devices do not have a required power-on sequence.

## GTP Transceiver DC Input and Output Levels

Table 16 summarizes the DC output specifications of the GTP transceivers in Spartan-6 FPGAs. Figure 1 shows the single-ended output voltage swing. Figure 2 shows the peak-to-peak differential output voltage.

Consult [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) for further details.

Table 16: GTP Transceiver DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
DV <sub>PPIN</sub>	Differential peak-to-peak input voltage	External AC coupled	140	—	2000	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled MGTAVTTRX = 1.2V	-400	—	MGTAVTTRX	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled MGTAVTTRX = 1.2V	—	3/4 MGTAVTTRX	—	mV
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	Transmitter output swing is set to maximum setting	—	—	1000	mV
V <sub>SEOUT</sub>	Single-ended output voltage <sup>(1)</sup>	—	—	—	500	mV
V <sub>CMOUTDC</sub>	Common mode output voltage	Equation based	MGTAVTTX - V <sub>SEOUT</sub> /2			mV
R <sub>IN</sub>	Differential input resistance	—	80	100	130	Ω
R <sub>OUT</sub>	Differential output resistance	—	80	100	130	Ω
T <sub>OSKEW</sub>	Transmitter output skew	—	—	—	15	ps
C <sub>EXT</sub>	Recommended external AC coupling capacitor <sup>(2)</sup>	—	75	100	200	nF

**Notes:**

- The output swing and preemphasis levels are programmable using the attributes discussed in [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) and can result in values lower than reported in this table.
- Other values can be used as appropriate to conform to specific protocols and standards.

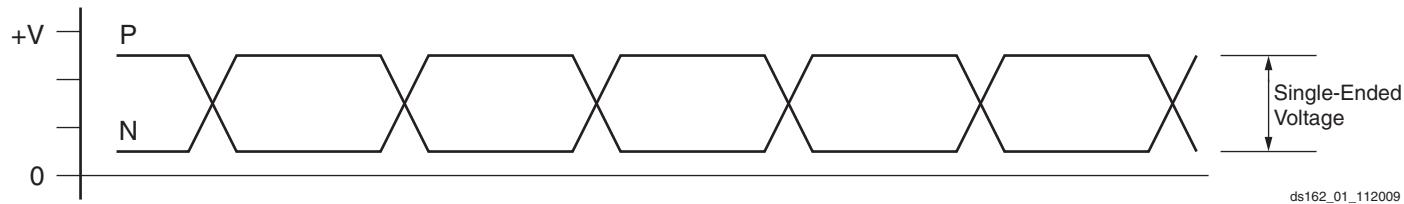


Figure 1: Single-Ended Peak-to-Peak Voltage

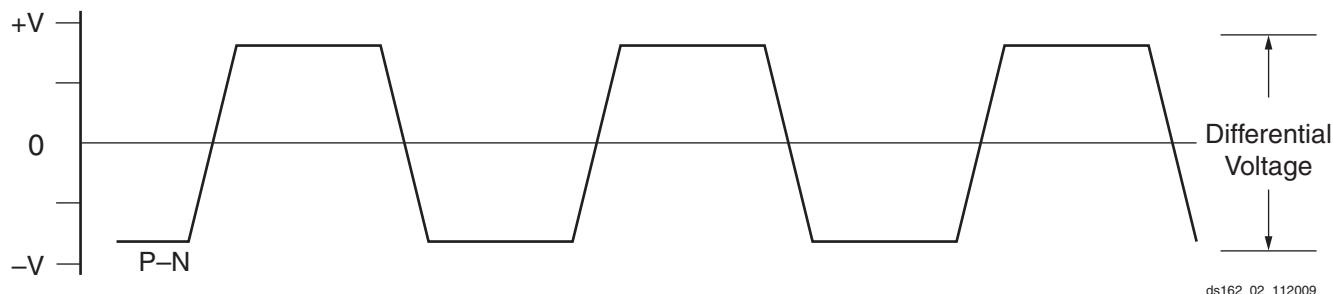


Figure 2: Differential Peak-to-Peak Voltage

Table 17 summarizes the DC specifications of the clock input of the GTP transceiver. Consult [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) for further details.

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Spartan-6 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [Switching Characteristics, page 19](#).

**Table 25: Interface Performances**

<b>Description</b>	<b>I/O Resource</b>	<b>Clock Buffer</b>	<b>Data Width</b>	<b>Speed Grade</b>				<b>Units</b>		
				<b>-3</b>	<b>-3N</b>	<b>-2</b>	<b>-1L</b>			
<b>Networking Applications<sup>(1)</sup></b>										
SDR LVDS transmitter or receiver	IOB SDR register	BUFG	—	400	400	375	250	Mb/s		
DDR LVDS transmitter or receiver	ODDR2/IDDR2 register	2 BUFGs	—	800	800	750	500	Mb/s		
SDR LVDS transmitter	OSERDES2	BUFPLL	2	500	500	500	250	Mb/s		
			3	750	750	750	375	Mb/s		
			4-8	1080	1050	950	500	Mb/s		
DDR LVDS transmitter	OSERDES2	2 BUFIO2s	2	500	500	500	250	Mb/s		
			3	750	750	750	375	Mb/s		
			4-8	1080	1050	950	500	Mb/s		
SDR LVDS receiver	ISERDES2 in RETIMED mode	BUFPLL	2	500	500	500	—	Mb/s		
			3	750	750	750	—	Mb/s		
			4-8	1080	1050	950	—	Mb/s		
DDR LVDS receiver	ISERDES2 in RETIMED mode	2 BUFIO2s	2	500	500	500	—	Mb/s		
			3	750	750	750	—	Mb/s		
			4-8	1080	1050	950	—	Mb/s		
<b>Memory Interfaces (Implemented using the Spartan-6 FPGA Memory Controller Block)<sup>(2)</sup></b>										
<b>Standard Performance (Standard V<sub>CCINT</sub>)</b>										
DDR				400	<a href="#">Note 4</a>	400	350	Mb/s		
DDR2				667	<a href="#">Note 4</a>	625	400	Mb/s		
DDR3				800	<a href="#">Note 4</a>	667	—	Mb/s		
LPDDR (Mobile_DDR)				400	<a href="#">Note 4</a>	400	350	Mb/s		
<b>Extended Performance (Requires Extended Performance V<sub>CCINT</sub>)<sup>(3)</sup></b>										
DDR2				800	<a href="#">Note 4</a>	667	—	Mb/s		

**Notes:**

- Refer to [XAPP1064](#), *Source-Synchronous Serialization and Deserialization (up to 1050 Mb/s)* and [UG381](#), *Spartan-6 FPGA SelectIO Resources User Guide*.
- Refer to [UG388](#), *Spartan-6 FPGA Memory Controller User Guide*.
- Extended Memory Controller block performance for DDR2 can be achieved using the extended performance V<sub>CCINT</sub> range from [Table 2](#).
- The LX4 device, all devices in the TQG144 and CPG196 packages, and the -3N speed grade do not support a Memory Controller Block.

## Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases. [Table 27](#) lists the production released Spartan-6 family member, speed grade, and the minimum corresponding supported speed specification version and ISE® software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

**Table 27: Spartan-6 Device Production Software and Speed Specification Release<sup>(1)</sup>**

Device	Speed Grade Designations <sup>(2)</sup>			
	-3 <sup>(3)</sup>	-3N	-2 <sup>(4)</sup>	-1L
XC6SLX4	ISE 12.4 v1.15	N/A	ISE 12.3 v1.12 <sup>(5)</sup>	ISE 13.2 v1.07
XC6SLX9	ISE 12.4 v1.15	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.3 v1.12 <sup>(5)</sup>	ISE 13.2 v1.07
XC6SLX16	ISE 12.1 v1.08	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 11.5 v1.06	ISE 13.2 v1.07
XC6SLX25	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.2 v1.07
XC6SLX25T	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	N/A
XC6SLX45	ISE 12.1 v1.08	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 11.5 v1.07	ISE 13.1 v1.06
XC6SLX45T	ISE 12.1 v1.08	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.1 v1.08	N/A
XC6SLX75	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.2 v1.07
XC6SLX75T	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	N/A
XC6SLX100	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 v1.06
XC6SLX100T	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	N/A
XC6SLX150	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 v1.06
XC6SLX150T	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	N/A
XA6SLX4	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX9	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX16	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX25	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX25T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX45	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX45T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX75	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX75T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX100	N/A	N/A	ISE 13.3 v1.20	N/A

Table 27: Spartan-6 Device Production Software and Speed Specification Release<sup>(1)</sup> (Cont'd)

Device	Speed Grade Designations <sup>(2)</sup>			
	-3 <sup>(3)</sup>	-3N	-2 <sup>(4)</sup>	-1L
XQ6SLX75	N/A	N/A	ISE 13.2 v1.19	ISE 13.2 v1.07
XQ6SLX75T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XQ6SLX150	N/A	N/A	ISE 13.2 v1.19	ISE 13.2 v1.07
XQ6SLX150T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A

**Notes:**

1. ISE 13.3 software with v1.20 for -3, -3N, and -2; and v1.08 for -1L speed specification reflects the changes outlined in [XCN11028: Spartan-6 FPGA Speed File Changes](#).
2. As marked with an N/A, LXT devices and all XA devices are not available with a -1L speed grade; LX4 devices and all XA and XQ devices are not available with a -3N speed grade.
3. Improved -3 specifications reflected in this data sheet require ISE 12.4 software with v1.15 speed specification.
4. Improved -2 specifications reflected in this data sheet require ISE 12.4 software and the *12.4 Speed Files Patch* which contains the v1.17 speed specification available on the [Xilinx Download Center](#).
5. ISE 12.3 software with v1.12 speed specification is available using ISE 12.3 software and the *12.3 Speed Files Patch* available on the [Xilinx Download Center](#).
6. ISE 12.2 software with v1.11 speed specification is available using ISE 12.2 software and the *12.2 Speed Files Patch* available on the [Xilinx Download Center](#).
7. ISE 13.1 software with v1.18 speed specification is available using ISE 13.1 software and the *13.1 Update* available on the [Xilinx Download Center](#). See [XCN11012: Speed File Change for -3N Devices](#).

**IOB Pad Input/Output/3-State Switching Characteristics**

**Table 28** (for commercial (XC) Spartan-6 devices) and **Table 29** (for Automotive XA Spartan-6 and Defense-grade Spartan-6Q devices) summarizes the values of standard-specific data input delays, output delays terminating at pads (based on standard), and 3-state delays.

- $T_{IOP}$  is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.
- $T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.
- $T_{IOTP}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer.

See the TRACE report for further information on delays when using an I/O standard with UNTUNED termination on inputs or outputs.

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices

I/O Standard	$T_{IOP}$				$T_{IOOP}$				$T_{IOTP}$				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>		
LVDS_33	1.17	1.29	1.42	1.68	1.55	1.69	1.89	2.42	3000	3000	3000	3000	ns	
LVDS_25	1.01	1.13	1.26	1.57	1.65	1.79	1.99	2.47	3000	3000	3000	3000	ns	
BLVDS_25	1.02	1.14	1.27	1.57	1.72	1.86	2.06	2.68	1.72	1.86	2.06	2.68	ns	
MINI_LVDS_33	1.17	1.29	1.42	1.68	1.57	1.71	1.91	2.41	3000	3000	3000	3000	ns	
MINI_LVDS_25	1.01	1.13	1.26	1.57	1.65	1.79	1.99	2.47	3000	3000	3000	3000	ns	
LVPECL_33	1.18	1.30	1.43	1.68	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	ns	
LVPECL_25	1.02	1.14	1.27	1.57	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	ns	
RSDS_33 (point to point)	1.17	1.29	1.42	1.68	1.57	1.71	1.91	2.42	3000	3000	3000	3000	ns	
RSDS_25 (point to point)	1.01	1.13	1.26	1.56	1.65	1.79	1.99	2.47	3000	3000	3000	3000	ns	
TMDS_33	1.21	1.33	1.46	1.71	1.54	1.68	1.88	2.50	3000	3000	3000	3000	ns	

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>LOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>		
LVCMOS15, Slow, 8 mA	0.98	1.10	1.23	1.79	2.30	2.44	2.64	3.25	2.30	2.44	2.64	3.25	ns	
LVCMOS15, Slow, 12 mA	0.98	1.10	1.23	1.79	2.03	2.17	2.37	2.99	2.03	2.17	2.37	2.99	ns	
LVCMOS15, Slow, 16 mA	0.98	1.10	1.23	1.79	2.01	2.15	2.35	2.97	2.01	2.15	2.35	2.97	ns	
LVCMOS15, Fast, 2 mA	0.98	1.10	1.23	1.79	3.29	3.43	3.63	4.24	3.29	3.43	3.63	4.24	ns	
LVCMOS15, Fast, 4 mA	0.98	1.10	1.23	1.79	2.27	2.41	2.61	3.22	2.27	2.41	2.61	3.22	ns	
LVCMOS15, Fast, 6 mA	0.98	1.10	1.23	1.79	1.78	1.92	2.12	2.74	1.78	1.92	2.12	2.74	ns	
LVCMOS15, Fast, 8 mA	0.98	1.10	1.23	1.79	1.73	1.87	2.07	2.69	1.73	1.87	2.07	2.69	ns	
LVCMOS15, Fast, 12 mA	0.98	1.10	1.23	1.79	1.73	1.87	2.07	2.64	1.73	1.87	2.07	2.64	ns	
LVCMOS15, Fast, 16 mA	0.98	1.10	1.23	1.79	1.73	1.87	2.07	2.64	1.73	1.87	2.07	2.64	ns	
LVCMOS15_JEDEC, QUIETIO, 2 mA	1.03	1.15	1.28	1.49	5.49	5.63	5.83	6.37	5.49	5.63	5.83	6.37	ns	
LVCMOS15_JEDEC, QUIETIO, 4 mA	1.03	1.15	1.28	1.49	4.61	4.75	4.95	5.51	4.61	4.75	4.95	5.51	ns	
LVCMOS15_JEDEC, QUIETIO, 6 mA	1.03	1.15	1.28	1.49	4.07	4.21	4.41	4.97	4.07	4.21	4.41	4.97	ns	
LVCMOS15_JEDEC, QUIETIO, 8 mA	1.03	1.15	1.28	1.49	3.92	4.06	4.26	4.81	3.92	4.06	4.26	4.81	ns	
LVCMOS15_JEDEC, QUIETIO, 12 mA	1.03	1.15	1.28	1.49	3.54	3.68	3.88	4.51	3.54	3.68	3.88	4.51	ns	
LVCMOS15_JEDEC, QUIETIO, 16 mA	1.03	1.15	1.28	1.49	3.33	3.47	3.67	4.31	3.33	3.47	3.67	4.31	ns	
LVCMOS15_JEDEC, Slow, 2 mA	1.03	1.15	1.28	1.49	4.18	4.32	4.52	5.13	4.18	4.32	4.52	5.13	ns	
LVCMOS15_JEDEC, Slow, 4 mA	1.03	1.15	1.28	1.49	3.42	3.56	3.76	4.35	3.42	3.56	3.76	4.35	ns	
LVCMOS15_JEDEC, Slow, 6 mA	1.03	1.15	1.28	1.49	2.29	2.43	2.63	3.25	2.29	2.43	2.63	3.25	ns	
LVCMOS15_JEDEC, Slow, 8 mA	1.03	1.15	1.28	1.49	2.30	2.44	2.64	3.26	2.30	2.44	2.64	3.26	ns	
LVCMOS15_JEDEC, Slow, 12 mA	1.03	1.15	1.28	1.49	2.01	2.15	2.35	2.97	2.01	2.15	2.35	2.97	ns	
LVCMOS15_JEDEC, Slow, 16 mA	1.03	1.15	1.28	1.49	2.01	2.15	2.35	2.97	2.01	2.15	2.35	2.97	ns	
LVCMOS15_JEDEC, Fast, 2 mA	1.03	1.15	1.28	1.49	3.28	3.42	3.62	4.22	3.28	3.42	3.62	4.22	ns	
LVCMOS15_JEDEC, Fast, 4 mA	1.03	1.15	1.28	1.49	2.27	2.41	2.61	3.23	2.27	2.41	2.61	3.23	ns	
LVCMOS15_JEDEC, Fast, 6 mA	1.03	1.15	1.28	1.49	1.78	1.92	2.12	2.74	1.78	1.92	2.12	2.74	ns	
LVCMOS15_JEDEC, Fast, 8 mA	1.03	1.15	1.28	1.49	1.73	1.87	2.07	2.69	1.73	1.87	2.07	2.69	ns	
LVCMOS15_JEDEC, Fast, 12 mA	1.03	1.15	1.28	1.49	1.73	1.87	2.07	2.63	1.73	1.87	2.07	2.63	ns	
LVCMOS15_JEDEC, Fast, 16 mA	1.03	1.15	1.28	1.49	1.73	1.87	2.07	2.63	1.73	1.87	2.07	2.63	ns	
LVCMOS12, QUIETIO, 2 mA	0.91	1.03	1.16	1.51	6.40	6.54	6.74	7.30	6.40	6.54	6.74	7.30	ns	
LVCMOS12, QUIETIO, 4 mA	0.91	1.03	1.16	1.51	4.98	5.12	5.32	5.90	4.98	5.12	5.32	5.90	ns	
LVCMOS12, QUIETIO, 6 mA	0.91	1.03	1.16	1.51	4.65	4.79	4.99	5.55	4.65	4.79	4.99	5.55	ns	
LVCMOS12, QUIETIO, 8 mA	0.91	1.03	1.16	1.51	4.23	4.37	4.57	5.21	4.23	4.37	4.57	5.21	ns	
LVCMOS12, QUIETIO, 12 mA	0.91	1.03	1.16	1.51	3.98	4.12	4.32	4.94	3.98	4.12	4.32	4.94	ns	
LVCMOS12, Slow, 2 mA	0.91	1.03	1.16	1.51	4.98	5.12	5.32	5.91	4.98	5.12	5.32	5.91	ns	
LVCMOS12, Slow, 4 mA	0.91	1.03	1.16	1.51	2.84	2.98	3.18	3.81	2.84	2.98	3.18	3.81	ns	
LVCMOS12, Slow, 6 mA	0.91	1.03	1.16	1.51	2.77	2.91	3.11	3.72	2.77	2.91	3.11	3.72	ns	
LVCMOS12, Slow, 8 mA	0.91	1.03	1.16	1.51	2.34	2.48	2.68	3.31	2.34	2.48	2.68	3.31	ns	
LVCMOS12, Slow, 12 mA	0.91	1.03	1.16	1.51	2.08	2.22	2.42	3.06	2.08	2.22	2.42	3.06	ns	

Table 34: SSO Limit per V<sub>CCO</sub>/GND Pair (Cont'd)

V <sub>CCO</sub>	I/O Standard	Drive	Slew	SSO Limit per V <sub>CCO</sub> /GND Pair					
				All TQG144, CPG196, CSG225, FT(G)256, and LX devices in CSG324		All CS(G)484, FG(G)484, FG(G)676, FG(G)900, and LXT devices in CSG324			
				Bank 0/2	Bank 1/3	Bank 0/2	Bank 1/3/4/5		
2.5V	LVCMS25	2	Fast	38	43	38	43		
			Slow	46	52	46	48		
			QuietIO	57	64	57	59		
		4	Fast	21	24	21	23		
			Slow	26	31	26	27		
			QuietIO	33	32	33	30		
		6	Fast	15	17	15	16		
			Slow	19	22	19	19		
			QuietIO	25	23	25	19		
		8	Fast	12	15	12	14		
			Slow	15	18	15	16		
			QuietIO	21	19	21	16		
		12	Fast	1	3	1	1		
			Slow	2	7	2	4		
			QuietIO	3	8	3	8		
		16	Fast	1	3	1	1		
			Slow	3	7	3	3		
			QuietIO	4	9	4	8		
		24	Fast	N/A	3	N/A	1		
			Slow	N/A	5	N/A	2		
			QuietIO	N/A	8	N/A	6		
SSTL_2_I <sup>(3)</sup>				10	11	10	11		
SSTL_2_II <sup>(3)</sup>				N/A	7	N/A	7		
DIFF_SSTL_2_I <sup>(3)</sup>				30	33	30	33		
DIFF_SSTL_2_II <sup>(3)</sup>				N/A	21	N/A	24		

Table 57: Switching Characteristics for the Digital Frequency Synthesizer DFS (DCM\_CLKGEN)<sup>(1)</sup> (Cont'd)

Symbol	Description	Speed Grade								Units	
		-3		-3N		-2		-1L			
		Min	Max	Min	Max	Min	Max	Min	Max		
<b>Spread Spectrum</b>											
F_CLKIN_FIXED_SPREAD_SPECTRUM	Frequency of the CLKIN input for fixed spread spectrum (SPREAD_SPECTRUM = CENTER_LOW_SPREAD / CENTER_HIGH_SPREAD)	30	200	30	200	30	200	30	200	MHz	
T_CENTER_LOW_SPREAD <sup>(6)</sup>	Spread at the CLKFX output for fixed spread spectrum (SPREAD_SPECTRUM = CENTER_LOW_SPREAD)	Typical = $\frac{100}{\text{CLKFX\_DIVIDE}}$ Maximum = 250								ps	
T_CENTER_HIGH_SPREAD <sup>(6)</sup>	Spread at the CLKFX output for fixed spread spectrum (SPREAD_SPECTRUM = CENTER_HIGH_SPREAD)	Typical = $\frac{240}{\text{CLKFX\_DIVIDE}}$ Maximum = 400								ps	
F_MOD_FIXED_SPREAD_SPECTRUM <sup>(6)</sup>	Average modulation frequency when using fixed spread spectrum (SPREAD_SPECTRUM = CENTER_LOW_SPREAD / CENTER_HIGH_SPREAD)	Typical = $F_{IN}/1024$								MHz	

**Notes:**

- The values in this table are based on the operating conditions described in Table 2 and Table 55.
- For optimal jitter tolerance and a faster LOCK time, use the CLKIN\_PERIOD attribute.
- Output jitter is characterized with no input jitter. Output jitter strongly depends on the environment, including the number of SSOs, the output drive strength, CLB utilization, CLB switching activities, switching frequency, power supply, and PCB design. The actual maximum output jitter depends on the system application.
- The CLKFX, CLKFXDV, and CLKFX180 outputs have a duty cycle of approximately 50%.
- Some duty-cycle and alignment specifications include a percentage of the CLKFX output period. For example, this data sheet specifies a maximum CLKFX jitter of  $\pm(1\% \text{ of CLKFX period} + 200 \text{ ps})$ . Assuming that the CLKFX output frequency is 100 MHz, the equivalent CLKFX period is 10 ns, and 1% of 10 ns is 0.1 ns or 100 ps. Accordingly, the maximum jitter is  $\pm(100 \text{ ps} + 200 \text{ ps}) = \pm300 \text{ ps}$ .
- When using CENTER\_LOW\_SPREAD, CENTER\_HIGH\_SPREAD, the valid values for CLKFX\_MULTIPLY are limited to 2 through 32, and the valid values for CLKFX\_DIVIDE are limited to 1 through 4.

Table 58: Recommended Operating Conditions for the Phase-Shift Clock in Variable Phase Mode (DCM\_SP) or Dynamic Frequency Synthesis (DCM\_CLKGEN)

Symbol	Description	Speed Grade								Units	
		-3		-3N		-2		-1L			
		Min	Max	Min	Max	Min	Max	Min	Max		
<b>Operating Frequency Ranges</b>											
PSCLK_FREQ	Frequency for the PSCLK (DCM_SP) or PROGCLK (DCM_CLKGEN) input.	1	167	1	167	1	167	1	100	MHz	
<b>Input Pulse Requirements</b>											
PSCLK_PULSE	PSCLK (DCM_SP) or PROGCLK (DCM_CLKGEN) pulse width as a percentage of the clock period.	40	60	40	60	40	60	40	60	%	

Table 69: Global Clock Input to Output Delay With DCM and PLL in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
LVCMOS25 Global Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>with</i> DCM in Source-Synchronous Mode and PLL in DCM2PLL Mode.							
TICKOFDCM0_PLL	Global Clock and OUTFF with DCM and PLL	XC6SLX4	5.58	N/A	7.42	8.54	ns
		XC6SLX9	5.58	6.19	7.42	8.54	ns
		XC6SLX16	5.50	6.06	7.05	8.24	ns
		XC6SLX25	5.57	6.04	7.02	8.33	ns
		XC6SLX25T	5.57	6.04	7.02	N/A	ns
		XC6SLX45	5.53	5.97	6.96	8.32	ns
		XC6SLX45T	5.53	5.97	6.96	N/A	ns
		XC6SLX75	5.55	6.00	6.99	8.54	ns
		XC6SLX75T	5.55	6.00	6.99	N/A	ns
		XC6SLX100	5.58	6.03	7.02	9.11	ns
		XC6SLX100T	5.62	6.03	7.02	N/A	ns
		XC6SLX150	5.32	5.70	6.41	8.26	ns
		XC6SLX150T	5.32	5.70	6.41	N/A	ns
		XA6SLX4	5.87	N/A	7.28	N/A	ns
		XA6SLX9	5.87	N/A	7.28	N/A	ns
		XA6SLX16	6.02	N/A	6.87	N/A	ns
		XA6SLX25	5.88	N/A	6.90	N/A	ns
		XA6SLX25T	5.88	N/A	7.00	N/A	ns
		XA6SLX45	5.82	N/A	6.81	N/A	ns
		XA6SLX45T	5.82	N/A	6.81	N/A	ns
		XA6SLX75	5.81	N/A	6.80	N/A	ns
		XA6SLX75T	5.81	N/A	6.80	N/A	ns
		XA6SLX100	N/A	N/A	6.88	N/A	ns
		XQ6SLX75	N/A	N/A	6.80	8.54	ns
		XQ6SLX75T	5.81	N/A	6.80	N/A	ns
		XQ6SLX150	N/A	N/A	6.41	8.26	ns
		XQ6SLX150T	5.90	N/A	6.41	N/A	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. DCM and PLL output jitter are already included in the timing calculation.

## Spartan-6 Device Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. The representative values for typical pin locations and normal clock loading are listed in [Table 70](#) through [Table 77](#). Values are expressed in nanoseconds unless otherwise noted.

**Table 70: Global Clock Setup and Hold Without DCM or PLL (No Delay)**

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMS25 Standard.<sup>(1)</sup></b>							
$T_{PSND}/T_{PHND}$	No Delay Global Clock and IFF <sup>(3)</sup> without DCM or PLL	XC6SLX4	0.10/1.56	N/A	0.10/1.83	0.07/2.54	ns
		XC6SLX9	0.10/1.56	0.10/1.57	0.10/1.84	0.07/2.54	ns
		XC6SLX16	0.12/1.42	0.12/1.48	0.12/1.64	0.13/2.19	ns
		XC6SLX25	0.18/1.64	0.18/1.75	0.18/1.99	0.11/2.57	ns
		XC6SLX25T	0.18/1.64	0.18/1.75	0.18/1.99	N/A	ns
		XC6SLX45	-0.08/1.80	-0.08/1.95	-0.08/2.27	-0.17/2.74	ns
		XC6SLX45T	-0.08/1.80	-0.08/1.95	-0.08/2.27	N/A	ns
		XC6SLX75	0.13/1.81	0.13/2.06	0.13/2.27	-0.12/3.30	ns
		XC6SLX75T	0.13/1.81	0.13/2.06	0.13/2.27	N/A	ns
		XC6SLX100	-0.14/2.03	-0.14/2.24	-0.14/2.56	-0.17/3.44	ns
		XC6SLX100T	-0.14/2.03	-0.14/2.24	-0.14/2.56	N/A	ns
		XC6SLX150	-0.24/2.42	-0.24/2.74	-0.24/2.95	-0.60/3.75	ns
		XC6SLX150T	-0.24/2.42	-0.24/2.74	-0.24/2.95	N/A	ns
		XA6SLX4	0.10/1.57	N/A	0.10/1.84	N/A	ns
		XA6SLX9	0.10/1.57	N/A	0.10/1.84	N/A	ns
		XA6SLX16	0.12/1.43	N/A	0.12/1.64	N/A	ns
		XA6SLX25	0.18/1.65	N/A	0.18/1.99	N/A	ns
		XA6SLX25T	0.18/1.65	N/A	0.18/1.99	N/A	ns
		XA6SLX45	-0.08/1.82	N/A	-0.08/2.27	N/A	ns
		XA6SLX45T	-0.08/1.82	N/A	-0.08/2.27	N/A	ns
		XA6SLX75	0.13/2.02	N/A	0.13/2.32	N/A	ns
		XA6SLX75T	0.13/2.02	N/A	0.13/2.32	N/A	ns
		XA6SLX100	N/A	N/A	0.10/2.51	N/A	ns
		XQ6SLX75	N/A	N/A	0.13/2.32	-0.12/3.30	ns
		XQ6SLX75T	0.13/2.02	N/A	0.13/2.32	N/A	ns
		XQ6SLX150	N/A	N/A	-0.24/2.95	-0.60/3.75	ns
		XQ6SLX150T	-0.24/2.74	N/A	-0.24/2.95	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch.

Table 72: Global Clock Setup and Hold With DCM in System-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSDCM</sub> / T <sub>PHDCM</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in System-Synchronous Mode	XC6SLX4	1.54/0.06	N/A	1.75/0.12	2.84/0.27	ns
		XC6SLX9	1.54/0.06	1.63/0.12	1.75/0.12	2.84/0.27	ns
		XC6SLX16	1.72/-0.18	1.87/-0.17	2.13/-0.17	2.31/0.26	ns
		XC6SLX25	1.70/-0.03	1.78/-0.02	2.00/-0.02	2.88/0.20	ns
		XC6SLX25T	1.70/0.07	1.78/0.08	2.00/0.08	N/A	ns
		XC6SLX45	1.74/-0.03	1.84/-0.02	2.02/-0.02	2.64/0.52	ns
		XC6SLX45T	1.74/-0.01	1.84/0.00	2.02/0.00	N/A	ns
		XC6SLX75	1.86/0.11	1.98/0.12	2.20/0.12	2.96/0.58	ns
		XC6SLX75T	1.86/0.11	1.98/0.12	2.20/0.12	N/A	ns
		XC6SLX100	1.64/0.07	1.72/0.08	1.97/0.08	2.70/0.99	ns
		XC6SLX100T	1.64/0.09	1.72/0.10	1.97/0.10	N/A	ns
		XC6SLX150	1.53/0.39	1.62/0.40	1.82/0.40	2.75/1.00	ns
		XC6SLX150T	1.53/0.39	1.62/0.40	1.82/0.40	N/A	ns
		XA6SLX4	1.65/0.16	N/A	1.75/0.26	N/A	ns
		XA6SLX9	1.65/0.16	N/A	1.75/0.26	N/A	ns
		XA6SLX16	1.88/0.02	N/A	2.13/0.03	N/A	ns
		XA6SLX25	1.80/0.16	N/A	2.05/0.17	N/A	ns
		XA6SLX25T	1.80/0.16	N/A	2.13/0.17	N/A	ns
		XA6SLX45	1.75/0.12	N/A	2.02/0.13	N/A	ns
		XA6SLX45T	1.75/0.12	N/A	2.02/0.13	N/A	ns
		XA6SLX75	1.87/0.11	N/A	2.20/0.12	N/A	ns
		XA6SLX75T	1.87/0.11	N/A	2.20/0.12	N/A	ns
		XA6SLX100	N/A	N/A	2.46/0.24	N/A	ns
		XQ6SLX75	N/A	N/A	2.20/0.12	2.96/0.58	ns
		XQ6SLX75T	1.87/0.11	N/A	2.20/0.12	N/A	ns
		XQ6SLX150	N/A	N/A	1.82/0.56	2.75/1.00	ns
		XQ6SLX150T	1.65/0.55	N/A	1.82/0.56	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include DCM CLK0 jitter.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 73: Global Clock Setup and Hold With DCM in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSDCM0</sub> / T <sub>PHDCM0</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in Source-Synchronous Mode	XC6SLX4	0.71/0.65	N/A	0.72/1.22	1.58/1.18	ns
		XC6SLX9	0.71/0.69	0.71/1.19	0.72/1.36	1.58/1.18	ns
		XC6SLX16	0.86/0.52	0.92/0.57	1.04/0.60	1.02/1.06	ns
		XC6SLX25	0.84/0.58	0.90/0.59	1.01/0.59	1.58/1.07	ns
		XC6SLX25T	0.84/0.58	0.90/0.59	1.01/0.59	N/A	ns
		XC6SLX45	0.85/0.70	0.90/0.76	0.98/0.79	1.34/1.34	ns
		XC6SLX45T	0.85/0.70	0.90/0.76	0.98/0.79	N/A	ns
		XC6SLX75	1.00/0.62	1.06/0.63	1.15/0.63	1.65/1.46	ns
		XC6SLX75T	1.00/0.71	1.06/0.72	1.15/0.72	N/A	ns
		XC6SLX100	0.81/0.68	0.81/0.69	0.94/0.69	1.42/2.07	ns
		XC6SLX100T	0.81/0.68	0.81/0.69	0.94/0.69	N/A	ns
		XC6SLX150	0.68/0.98	0.69/0.99	0.79/0.99	1.45/1.60	ns
		XC6SLX150T	0.68/0.98	0.69/0.99	0.79/0.99	N/A	ns
		XA6SLX4	0.81/0.74	N/A	0.72/1.36	N/A	ns
		XA6SLX9	0.81/0.74	N/A	0.72/1.36	N/A	ns
		XA6SLX16	1.01/0.56	N/A	1.04/0.60	N/A	ns
		XA6SLX25	0.94/0.76	N/A	1.06/0.77	N/A	ns
		XA6SLX25T	0.94/0.76	N/A	1.14/0.77	N/A	ns
		XA6SLX45	0.86/0.74	N/A	0.98/0.78	N/A	ns
		XA6SLX45T	0.86/0.74	N/A	0.98/0.78	N/A	ns
		XA6SLX75	1.02/0.71	N/A	1.15/0.72	N/A	ns
		XA6SLX75T	1.02/0.71	N/A	1.15/0.72	N/A	ns
		XA6SLX100	N/A	N/A	1.37/0.75	N/A	ns
		XQ6SLX75	N/A	N/A	1.15/0.72	1.65/1.46	ns
		XQ6SLX75T	1.02/0.71	N/A	1.15/0.72	N/A	ns
		XQ6SLX150	N/A	N/A	0.79/1.15	1.45/1.60	ns
		XQ6SLX150T	0.73/1.15	N/A	0.79/1.15	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include DCM CLK0 jitter.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 74: Global Clock Setup and Hold With PLL in System-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSPLL</sub> / T <sub>PHPLL</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with PLL in System-Synchronous Mode	XC6SLX4	1.37/0.25	N/A	1.52/0.41	2.07/0.69	ns
		XC6SLX9	1.37/0.21	1.48/0.21	1.52/0.26	2.07/0.69	ns
		XC6SLX16	1.33/-0.03	1.53/-0.02	1.60/-0.02	1.57/0.48	ns
		XC6SLX25	1.65/0.28	1.71/0.28	1.91/0.28	2.44/0.76	ns
		XC6SLX25T	1.65/0.28	1.71/0.28	1.91/0.28	N/A	ns
		XC6SLX45	1.55/0.18	1.64/0.18	1.75/0.18	2.02/0.90	ns
		XC6SLX45T	1.55/0.18	1.64/0.18	1.75/0.18	N/A	ns
		XC6SLX75	1.77/0.21	1.89/0.21	2.13/0.21	2.46/0.53	ns
		XC6SLX75T	1.77/0.21	1.89/0.21	2.13/0.21	N/A	ns
		XC6SLX100	1.44/0.32	1.52/0.32	1.70/0.32	1.78/0.86	ns
		XC6SLX100T	1.44/0.32	1.52/0.32	1.70/0.32	N/A	ns
		XC6SLX150	1.39/0.49	1.48/0.49	1.67/0.49	1.94/0.94	ns
		XC6SLX150T	1.39/0.49	1.48/0.49	1.67/0.49	N/A	ns
		XA6SLX4	1.61/0.10	N/A	1.64/0.28	N/A	ns
		XA6SLX9	1.61/0.10	N/A	1.64/0.28	N/A	ns
		XA6SLX16	1.89/-0.08	N/A	1.72/-0.08	N/A	ns
		XA6SLX25	1.85/0.16	N/A	2.08/0.16	N/A	ns
		XA6SLX25T	1.85/0.16	N/A	2.17/0.16	N/A	ns
		XA6SLX45	1.58/0.07	N/A	1.87/0.03	N/A	ns
		XA6SLX45T	1.58/0.07	N/A	1.87/0.03	N/A	ns
		XA6SLX75	1.80/0.06	N/A	2.25/0.06	N/A	ns
		XA6SLX75T	1.80/0.06	N/A	2.25/0.06	N/A	ns
		XA6SLX100	N/A	N/A	2.34/0.14	N/A	ns
		XQ6SLX75	N/A	N/A	2.25/0.06	2.46/0.53	ns
		XQ6SLX75T	1.80/0.06	N/A	2.25/0.06	N/A	ns
		XQ6SLX150	N/A	N/A	1.79/0.37	1.94/0.94	ns
		XQ6SLX150T	1.43/0.37	N/A	1.79/0.37	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include PLL CLKOUT0 jitter.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 75: Global Clock Setup and Hold With PLL in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSPLL0</sub> / T <sub>PHPPLL0</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with PLL in Source-Synchronous Mode	XC6SLX4	0.47/1.08	N/A	0.47/1.60	1.15/1.68	ns
		XC6SLX9	0.47/1.08	0.47/1.35	0.47/1.60	1.15/1.68	ns
		XC6SLX16	0.37/0.75	0.37/0.82	0.51/0.94	0.57/1.31	ns
		XC6SLX25	0.69/1.06	0.69/1.06	0.69/1.06	1.86/1.67	ns
		XC6SLX25T	0.69/1.06	0.69/1.06	0.69/1.06	N/A	ns
		XC6SLX45	0.57/1.05	0.65/1.10	0.65/1.18	1.02/1.65	ns
		XC6SLX45T	0.57/1.06	0.65/1.10	0.65/1.18	N/A	ns
		XC6SLX75	0.86/1.04	0.87/1.04	0.90/1.04	1.34/1.55	ns
		XC6SLX75T	0.86/1.04	0.87/1.04	0.90/1.04	N/A	ns
		XC6SLX100	0.53/1.13	0.54/1.13	0.55/1.13	0.89/2.39	ns
		XC6SLX100T	0.53/1.13	0.54/1.13	0.55/1.13	N/A	ns
		XC6SLX150	0.50/1.31	0.51/1.31	0.52/1.31	1.02/1.72	ns
		XC6SLX150T	0.50/1.31	0.51/1.31	0.52/1.31	N/A	ns
		XA6SLX4	0.71/0.93	N/A	0.62/1.47	N/A	ns
		XA6SLX9	0.71/0.93	N/A	0.62/1.47	N/A	ns
		XA6SLX16	0.92/0.69	N/A	0.63/0.82	N/A	ns
		XA6SLX25	0.99/0.94	N/A	0.96/0.94	N/A	ns
		XA6SLX25T	0.99/0.94	N/A	1.04/0.94	N/A	ns
		XA6SLX45	0.63/1.02	N/A	0.72/1.05	N/A	ns
		XA6SLX45T	0.63/1.02	N/A	0.72/1.05	N/A	ns
		XA6SLX75	0.88/0.89	N/A	1.02/0.89	N/A	ns
		XA6SLX75T	0.88/0.89	N/A	1.02/0.89	N/A	ns
		XA6SLX100	N/A	N/A	1.25/0.96	N/A	ns
		XQ6SLX75	N/A	N/A	1.02/0.89	1.34/1.55	ns
		XQ6SLX75T	0.88/0.89	N/A	1.02/0.89	N/A	ns
		XQ6SLX150	N/A	N/A	0.63/1.19	1.02/1.72	ns
		XQ6SLX150T	0.60/1.19	N/A	0.63/1.19	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include PLL CLKOUT0 jitter.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 76: Global Clock Setup and Hold With DCM and PLL in System-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
$T_{PSDCMPLL}/T_{PHDCMPLL}$	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in System-Synchronous Mode and PLL in DCM2PLL Mode.	XC6SLX4	1.16/0.49	N/A	1.39/0.49	2.36/0.59	ns
		XC6SLX9	1.16/0.44	1.37/0.44	1.39/0.44	2.36/0.59	ns
		XC6SLX16	1.44/-0.08	1.49/-0.04	1.62/-0.04	2.06/0.55	ns
		XC6SLX25	1.52/0.42	1.65/0.42	1.83/0.42	2.52/0.43	ns
		XC6SLX25T	1.52/0.42	1.65/0.42	1.83/0.42	N/A	ns
		XC6SLX45	1.54/0.39	1.59/0.39	1.75/0.39	2.48/0.76	ns
		XC6SLX45T	1.54/0.39	1.59/0.39	1.75/0.39	N/A	ns
		XC6SLX75	1.72/0.41	1.80/0.41	1.99/0.41	2.60/0.75	ns
		XC6SLX75T	1.72/0.41	1.80/0.41	1.99/0.41	N/A	ns
		XC6SLX100	1.34/0.51	1.46/0.51	1.64/0.51	2.12/0.90	ns
		XC6SLX100T	1.34/0.51	1.46/0.51	1.64/0.51	N/A	ns
		XC6SLX150	1.30/0.60	1.40/0.60	1.55/0.60	2.57/0.97	ns
		XC6SLX150T	1.30/0.60	1.40/0.60	1.55/0.60	N/A	ns
		XA6SLX4	1.58/0.37	N/A	1.58/0.37	N/A	ns
		XA6SLX9	1.58/0.37	N/A	1.58/0.37	N/A	ns
		XA6SLX16	2.67/0.35	N/A	2.67/0.17	N/A	ns
		XA6SLX25	1.74/0.27	N/A	1.95/0.27	N/A	ns
		XA6SLX25T	1.74/0.27	N/A	2.03/0.27	N/A	ns
		XA6SLX45	1.58/0.29	N/A	1.87/0.29	N/A	ns
		XA6SLX45T	1.58/0.29	N/A	1.87/0.29	N/A	ns
		XA6SLX75	1.74/0.24	N/A	2.11/0.24	N/A	ns
		XA6SLX75T	1.74/0.24	N/A	2.11/0.24	N/A	ns
		XA6SLX100	N/A	N/A	2.64/0.82	N/A	ns
		XQ6SLX75	N/A	N/A	2.11/0.24	2.60/0.75	ns
		XQ6SLX75T	1.74/0.24	N/A	2.11/0.24	N/A	ns
		XQ6SLX150	N/A	N/A	1.67/0.70	2.57/0.97	ns
		XQ6SLX150T	1.50/0.70	N/A	1.67/0.70	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include CMT jitter; DCM CLK0 driving PLL, PLL CLKOUT0 driving BUFG.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 81: Source-Synchronous Pin-to-Pin Setup/Hold and Clock-to-Out Using BUFI02

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFI02</b>							
T <sub>PSCS</sub> /T <sub>PHCS</sub>	IFF setup/hold using BUFI02 clock	XC6SLX4	0.57/0.94	N/A	0.95/1.12	0.27/1.56	ns
		XC6SLX9	0.40/0.95	0.50/0.96	0.60/1.12	0.27/1.56	ns
		XC6SLX16	0.48/0.74	0.55/0.75	0.69/0.83	1.27/1.31	ns
		XC6SLX25	0.28/1.02	0.28/1.12	0.28/1.24	0.15/1.78	ns
		XC6SLX25T	0.28/1.02	0.28/1.12	0.28/1.24	N/A	ns
		XC6SLX45	0.42/1.19	0.44/1.29	0.50/1.40	0.12/1.83	ns
		XC6SLX45T	0.42/1.19	0.44/1.29	0.50/1.40	N/A	ns
		XC6SLX75	0.38/1.48	0.38/1.63	0.38/1.84	0.05/2.78	ns
		XC6SLX75T	0.38/1.48	0.38/1.63	0.38/1.84	N/A	ns
		XC6SLX100	0.06/1.48	0.06/1.63	0.06/1.87	-0.03/2.72	ns
		XC6SLX100T	0.06/1.48	0.06/1.63	0.06/1.87	N/A	ns
		XC6SLX150	0.04/1.73	0.04/1.75	0.04/1.98	-0.08/3.07	ns
		XC6SLX150T	0.04/1.73	0.04/1.75	0.04/1.98	N/A	ns
		XA6SLX4	0.64/0.96	N/A	0.97/1.12	N/A	ns
		XA6SLX9	0.44/0.99	N/A	0.62/1.16	N/A	ns
		XA6SLX16	0.50/0.78	N/A	0.69/0.83	N/A	ns
		XA6SLX25	0.28/1.04	N/A	0.28/1.25	N/A	ns
		XA6SLX25T	0.28/1.04	N/A	0.28/1.25	N/A	ns
		XA6SLX45	0.43/1.21	N/A	0.50/1.40	N/A	ns
		XA6SLX45T	0.43/1.21	N/A	0.50/1.40	N/A	ns
		XA6SLX75	0.38/1.49	N/A	0.38/1.84	N/A	ns
		XA6SLX75T	0.38/1.49	N/A	0.38/1.84	N/A	ns
		XA6SLX100	N/A	N/A	1.01/1.63	N/A	ns
		XQ6SLX75	N/A	N/A	0.38/1.84	0.05/2.78	ns
		XQ6SLX75T	0.38/1.49	N/A	0.38/1.84	N/A	ns
		XQ6SLX150	N/A	N/A	0.04/1.98	-0.08/3.07	ns
		XQ6SLX150T	0.04/1.75	N/A	0.04/1.98	N/A	ns

Date	Version	Description of Revisions
09/14/11	2.4	<p>Production release of the XA6SLX4 and XA6SLX9 devices in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19. Added production released version of the XA6SLX100 to <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.3 software with -2 speed specification v1.20.</p> <p>Updated <math>R_{OUT\_TERM}</math> description in <a href="#">Table 4</a>. Fixed the LVPECL <math>V_H</math> error in <a href="#">Table 31</a>. Updated introduction in <a href="#">Simultaneously Switching Outputs</a>. Added the XA6SLX100 to <a href="#">Table 63</a> through <a href="#">Table 78</a>, and <a href="#">Table 81</a>. Added <a href="#">Note 4</a> to <a href="#">Table 78</a> because the <math>T_{CKSKEW}</math> for the XC6SLX100 is not the same as the <math>T_{CKSKEW}</math> for the XA6SLX100.</p> <p>Revised the revision history for version <a href="#">1.6</a> dated <a href="#">06/24/10</a>. Removed the parenthetical statement about the -3N speed grade: (specifications are identical to the -3 speed grade).</p>
10/17/11	3.0	<p>Changed the data sheet from Preliminary Product Specification to Product Specification.</p> <p>Updated the <a href="#">Switching Characteristics, page 19</a> speed specification version ISE v13.3 software to -2 and -3 speed specification v1.20 and -1L speed specification of v1.08. Also updated <a href="#">Note 1</a> in <a href="#">Table 27</a>.</p> <p>In <a href="#">Table 43, Block RAM Switching Characteristics</a>, the <math>F_{MAX}</math> value for the -2 speed grade has been changed from 260 MHz to 280 MHz.</p> <p>In <a href="#">Table 54, Switching Characteristics for the DLL</a>, a <a href="#">Note 6</a> was added and linked to CLKIN_CLKFB_PHASE.</p>

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